

ON Semiconductor®

## FCH023N65S3

# N-Channel SuperFET<sup>®</sup> III MOSFET 650 V, 75 A, 23 m $\Omega$

#### **Features**

- 700 V @ T<sub>J</sub> = 150°C
- Typ.  $R_{DS(on)} = 19.5 \text{ m}\Omega$
- Ultra Low Gate Charge (Typ. Q<sub>q</sub> = 222 nC)
- Low Effective Output Capacitance (Typ. C<sub>oss(eff.)</sub> = 1980 pF)
- 100% Avalanche Tested
- · RoHS Compliant

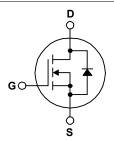
### **Applications**

- Telecom / Server Power Supplies UPS / Solar
- · Industrial Power Supply

## **Description**

SuperFET® III MOSFET is ON Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is uti-lizing charge balance technology for outstanding low on-resis-tance and lower gate charge performance. This advanced technology is tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate. Consequently, SuperFET III MOSFET is suitable for various DC/AC power conversion for system miniaturization and higher efficiency.





### Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted.

Symbol		Parameter		FCH023N65S3-F155	Unit
$V_{DSS}$	Drain to Source Voltage			650	V
M	Cata to Source Voltage	- DC		±30	V
$V_{GSS}$	Gate to Source Voltage	- AC	(f > 1 Hz)	±30	V
	Drain Current	- Continuous (T <sub>C</sub> = 25°C)		75	Α
ID	Drain Current	- Continuous (T <sub>C</sub> = 100°C)		65.8	A
I <sub>DM</sub>	Drain Current	- Pulsed	(Note 1)	300	Α
E <sub>AS</sub>	Single Pulsed Avalanche Energy	/	(Note 2)	2025	mJ
I <sub>AR</sub>	Avalanche Current		(Note 1)	15	Α
E <sub>AR</sub>	Repetitive Avalanche Energy		(Note 1)	5.95	mJ
dv/dt	MOSFET dv/dt		100	V/ns	
αν/αι	Peak Diode Recovery dv/dt		(Note 3)	20	V/IIS
D	Dower Dissipation	(T <sub>C</sub> = 25°C)		595	W
$P_{D}$	Power Dissipation  - Derate Above 25°C		4.76	W/°C	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Tempera	ture Range		-55 to +150	°C
T <sub>L</sub>	Maximum Lead Temperature for 1/8" from Case for 5 Seconds	Soldering,		300	°C

#### **Thermal Characteristics**

Symbol	Parameter	FCH023N65S3-F155	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	0.21	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max.	40	- 0/00

## **Package Marking and Ordering Information**

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FCH023N65S3-F155	FCH023N65S3	TO-247 G03	Tube	N/A	N/A	30 units

## **Electrical Characteristics** $T_C = 25^{\circ}C$ unless otherwise noted.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charae	cteristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$V_{GS} = 0 \text{ V, I}_{D} = 1 \text{ mA, T}_{J} = 25^{\circ}\text{C}$	650	-	-	V
		$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}, T_J = 150^{\circ}\text{C}$	700	-	-	
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 1 mA, Referenced to 25°C	-	0.72	-	V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 650 V, V <sub>GS</sub> = 0 V	-	-	1	
		$V_{DS} = 520 \text{ V}, T_{C} = 125^{\circ}\text{C}$	-	6.8	-	μΑ
I <sub>GSS</sub>	Gate to Body Leakage Current	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	±100	nA

#### **On Characteristics**

V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 7.5 \text{ mA}$	2.5	-	4.5	V
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	$V_{GS}$ = 10 V, $I_{D}$ = 37.5 A	-	19.5	23	mΩ
9 <sub>FS</sub>	Forward Transconductance	$V_{DS}$ = 20 V, $I_{D}$ = 37.5 A	-	66	-	S

#### **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 400 V, V <sub>GS</sub> = 0 V,	-	7160	-	pF
C <sub>oss</sub>	Output Capacitance	f = 1 MHz	-	195	-	pF
C <sub>oss(eff.)</sub>	Effective Output Capacitance	V <sub>DS</sub> = 0 V to 400 V, V <sub>GS</sub> = 0 V	-	1980	-	pF
C <sub>oss(er.)</sub>	Energy Related Output Capacitance	V <sub>DS</sub> = 0 V to 400 V, V <sub>GS</sub> = 0 V	-	298	-	
Q <sub>g(tot)</sub>	Total Gate Charge at 10V	V <sub>DS</sub> = 400 V, I <sub>D</sub> = 37.5 A,	-	222	-	nC
$Q_{gs}$	Gate to Source Gate Charge	V <sub>GS</sub> = 10 V	-	54	-	nC
$Q_{gd}$	Gate to Drain "Miller" Charge	(Note 4)	-	90	-	nC
ESR	Equivalent Series Resistance	f = 1 MHz	-	0.9	-	Ω

#### **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time			-	45	-	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{DD} = 400 \text{ V}, I_{D} = 37.5 \text{ A},$		-	55	-	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS}$ = 10 V, $R_g$ = 2 $\Omega$		-	140	-	ns
t <sub>f</sub>	Turn-Off Fall Time	4)	Note 4)	-	29	-	ns

#### **Drain-Source Diode Characteristics**

I <sub>S</sub>	Maximum Continuous Drain to Source Diode Forward Current		-	-	75	Α
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current		-	-	300	Α
$V_{SD}$	Drain to Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 37.5 A	-	-	1.2	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 37.5 A,	-	600	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$dI_F/dt = 100 A/\mu s$	-	17.9	-	μС

#### Notes

- 1. Repetitive rating: pulse width limited by maximum junction temperature.
- 2. I<sub>AS</sub> = 15 A, R<sub>G</sub> = 25  $\Omega$ , starting T<sub>J</sub> = 25°C.
- 3. I  $_{SD}$   $\leq$  75 A, di/dt  $\leq$  200 A/µs, V  $_{DD}$   $\leq$  BV  $_{DSS}$  , starting T  $_{J}$  = 25°C.
- 4. Essentially independent of operating temperature typical characteristics.

# **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

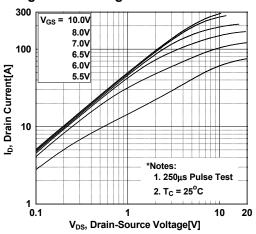


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

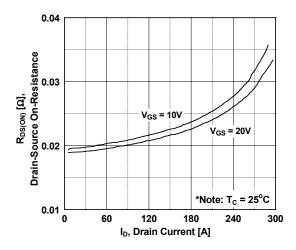
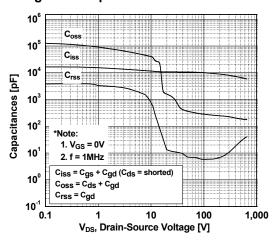


Figure 5. Capacitance Characteristics



**Figure 2. Transfer Characteristics** 

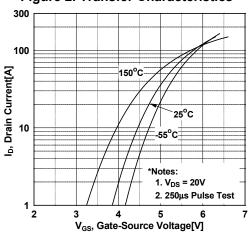


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

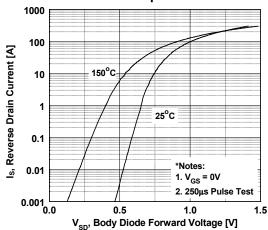
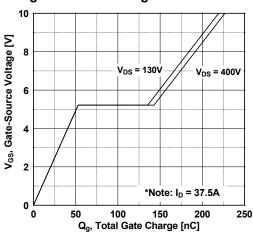


Figure 6. Gate Charge Characteristics



## **Typical Performance Characteristics** (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

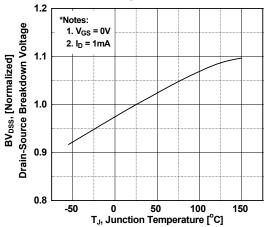


Figure 9. Maximum Safe Operating Area

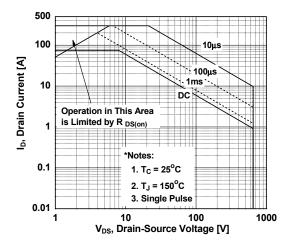


Figure 11. Eoss vs. Drain to Source Voltage

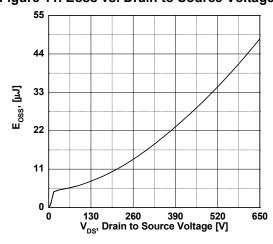


Figure 8. On-Resistance Variation vs. Temperature

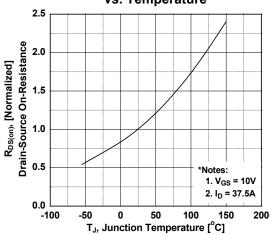
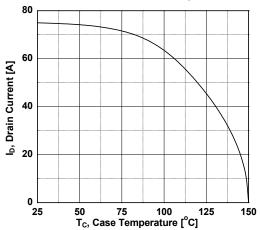
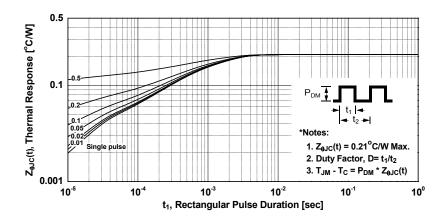


Figure 10. Maximum Drain Current vs. Case Temperature



## **Typical Performance Characteristics** (Continued)

Figure 12. Transient Thermal Response Curve



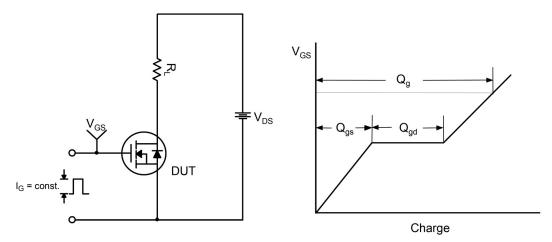


Figure 13. Gate Charge Test Circuit & Waveform

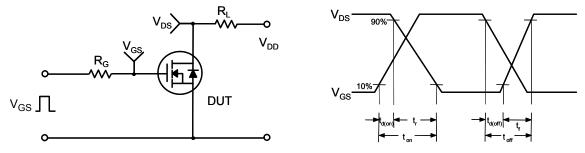


Figure 14. Resistive Switching Test Circuit & Waveforms

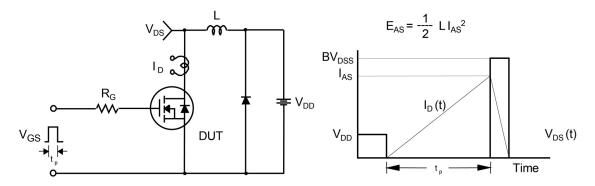
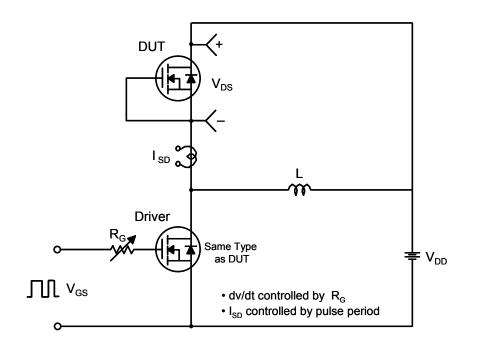


Figure 15. Unclamped Inductive Switching Test Circuit & Waveforms



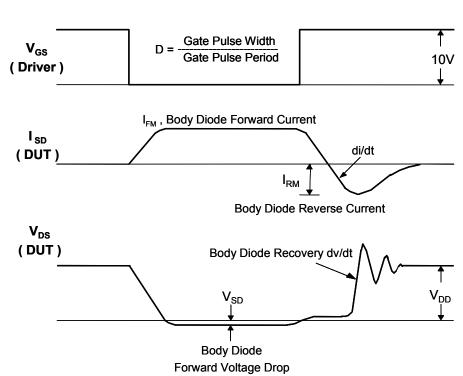


Figure 16. Peak Diode Recovery dv/dt Test Circuit & Waveforms

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